

<b>Notice of References Cited</b>	Application/Control No. 10/329,680	Applicant(s)/Patent Under Reexamination KWON, HO YUP	
	Examiner Long K. Tran	Art Unit 2818	Page 1 of 1

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*	B	US-6,017,823	01-2000	Shishiguchi et al.	438/696
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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